

RECIPIENT

SPECIFICATIONS

Product No. : X1G004691000300

MODEL : TG2016SBN 26.000000MHz TCNNNB

SPEC. No. : A15-820-0B

DATE : Aug. 11. 2015

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SPECIFICATIONS

1. Application

This document is applicable to the temperature compensated crystal oscillator (TCXO) that is delivered to from SEIKO EPSON Corp.

This product is compliant with RoHS Directive.

This Product supplied (and any technical information furnished, if any) by SEIKO EPSON Corporation shall not be used for the development and manufacture of weapon of mass destruction or for other military purposes.

Making available such products and technology to any third party who may use such products or technologies for the said purposes are also prohibited.

This product listed here is designed as components or parts for electronics equipment in general consumer use.

We do not expect that any of these products would be incorporated or otherwise used as a component or part for the equipment, which requires an extra high reliability, such as satellite, rocket and other space systems, and medical equipment, the functional purpose of which is to keep life.

2. Product No. / Model

The product No. of this crystal oscillator unit is **X1G004691000300**.

The model is **TG2016SBN 26.000000 MHz TCNNNB** (TCXO)

3. Packing

It is subject to the packing standard of SEIKO EPSON Corp.

4. Amendment and abolishment

Amendment and/or abolishment of this specification are subject to the agreement of both parties.

5. Contents

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[1] Characteristics

- Lead Free Reflowable and ultra small SMD(2.0 × 1.6 × 0.75 mm).
- Using the heat-resisting type AT cut quartz crystal allows almost the same temperature soldering as universal SMD IC.
- Output waveform : Clipped sine wave

[2] Absolute maximum ratings

Parameter	Symbol	Value	Unit	Note
Supply voltage	V _{CC-GND}	-0.3 to 4.0	V	
Storage temperature range	T _{STG}	-40 to +90	°C	

[3] Operating range

Parameter	Symbol	Value			Unit	Note
		Min.	Typ.	Max.		
Supply voltage	V _{CC}	1.7		3.63	V	
	GND	0.0		0.0		
Operating temperature range	T _{use}	-30	+25	+85	°C	
Output load	Load _R	9	10	11	kΩ	
	Load _C	9	10	11	pF	
DC-cut capacitor	C _C	0.01			μF	

DC-cut capacitor is not included in this TCXO.

Please attach an external DC-cut capacitor (0.01 μF Min.) to the out pin.

[4] Frequency characteristics

1) Output frequency 26.000000 MHz

2) Frequency characteristics

(Condition : $V_{CC} = 1.8V, 2.8V, 3.0V$ or $3.3V, GND = 0.0V, Load 10k\Omega//10pF(DC\ cut), T_{use} = +25^{\circ}C$)

Parameter	Symbol	Value			Unit	Note
		Min.		Max.		
Frequency tolerance	f_tol(osc)	-1.0	-	+1.0	$\times 10^{-6}$	$T_{use} = +25^{\circ}C \pm 2^{\circ}C$ Before Reflow soldering
	f_tol *1	-2.0	-	+2.0	$\times 10^{-6}$	$T_{use} = +25^{\circ}C \pm 2^{\circ}C$ After reflow : 2 times *2
Frequency / Temperature characteristics	fo-Tc	-0.5	-	+0.5	$\times 10^{-6}$	$T_{use} = -30^{\circ}C$ to $+85^{\circ}C$ (Based on frequency at $+25^{\circ}C$)
Frequency / Load coefficient	fo-Load	-0.2	-	+0.2	$\times 10^{-6}$	Load : $10k\Omega // 10pF \pm 10\%$ each
Frequency / Voltage coefficient	fo- V_{CC}	-0.2	-	+0.2	$\times 10^{-6}$	$V_{CC} \pm 5\%$ *3
Frequency aging	f_age	-1.0	-	+1.0	$\times 10^{-6}$	First year $T_{use} = +25^{\circ}C$

*1 Include initial frequency tolerance and frequency deviation after reflow cycles.

*2 Measurement of frequency deviation is made 24h after reflow soldering.

*3 $V_{CC} \pm 5\%$ must be in operating supply voltage range. (1.7V to 3.63V)

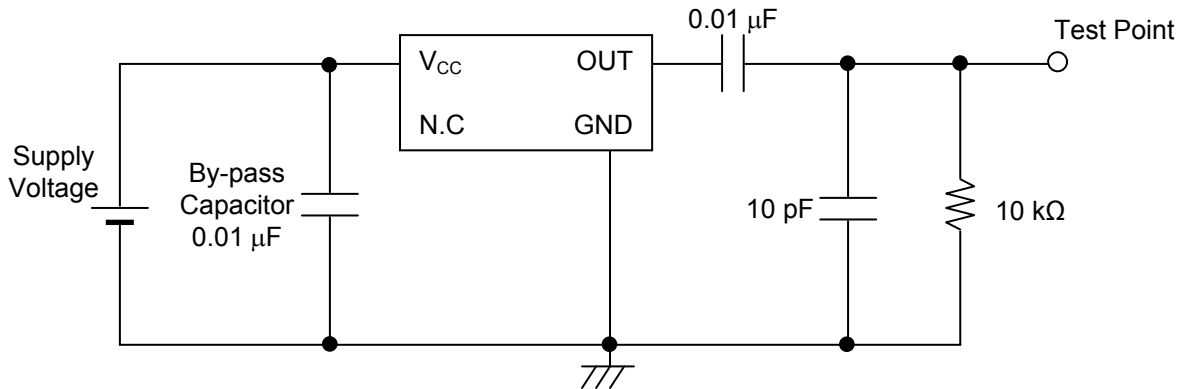
[5] Electrical characteristics

(Condition : $V_{CC} = 1.8V, 2.8V, 3.0V$ or $3.3V, GND = 0.0V, Load 10k\Omega//10pF(DC\ cut), T_{use} = +25^{\circ}C$)

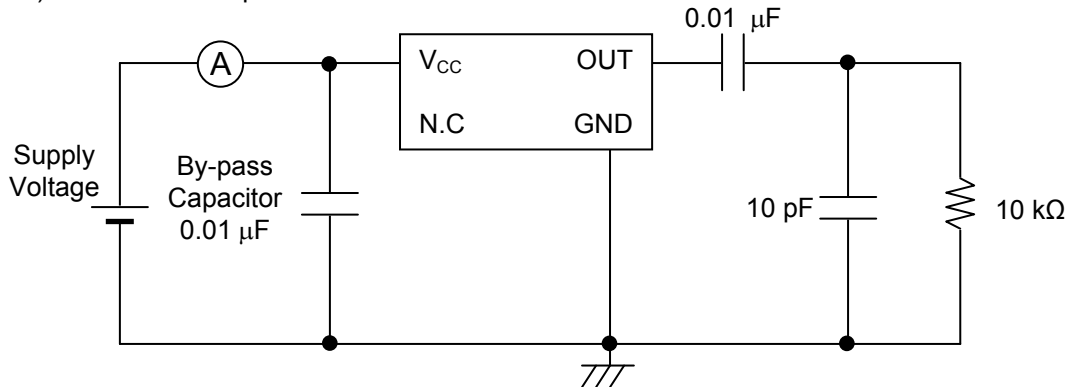
Parameter	Symbol	Value			Value	Note
		Min.	Typ.	Max.		
Current consumption	I_{CC}	-	-	2.0	mA	
Output level	V_{PP}	0.8	-	-	V	Peak to peak voltage Clipped sine wave
Symmetry	SYM	40	-	60	%	GND Level
Start up time	t_str	-	-	2.0	msec	Until frequency has been reached within $\pm 1 \times 10^{-6}$ of final frequency.
		-	-	2.0	msec	Until output signal has been reached min 90% of final amp.
SSB Phase noise	L(f)	-	-90	-	dBc /Hz	Offset : 10 Hz
		-	-116	-		Offset : 100 Hz
		-	-139	-		Offset : 1 kHz
		-	-151	-		Offset : 10 kHz
		-	-153	-		Offset : 100 kHz
		-	-154	-		Offset : 1 MHz

[6] Test circuit

1) Output Load : 10 k Ω //10 pF



2) Current consumption



3) Conditions

- | | | |
|------------------|-------------------|-------------------|
| 1. Oscilloscope: | Impedance | Min. 1 M Ω |
| | Input capacitance | Max. 10 pF |
| | Band width | Min. 300 MHz |

Impossible to measure both frequency and wave form at the same time. (In case of using oscilloscope's amplifier output, possible to measure both at the same time.)

2. Load_C includes probe capacitance.
3. A capacitor (By-pass: 0.01 μ F) is placed between V_{CC} and GND, and closely to TCXO.
4. Use the current meter whose internal impedance value is small.
5. Power Supply
Impedance of power supply should be as low as possible.
6. GND pin should be connected to low impedance GND

[7] Environmental and mechanical characteristics

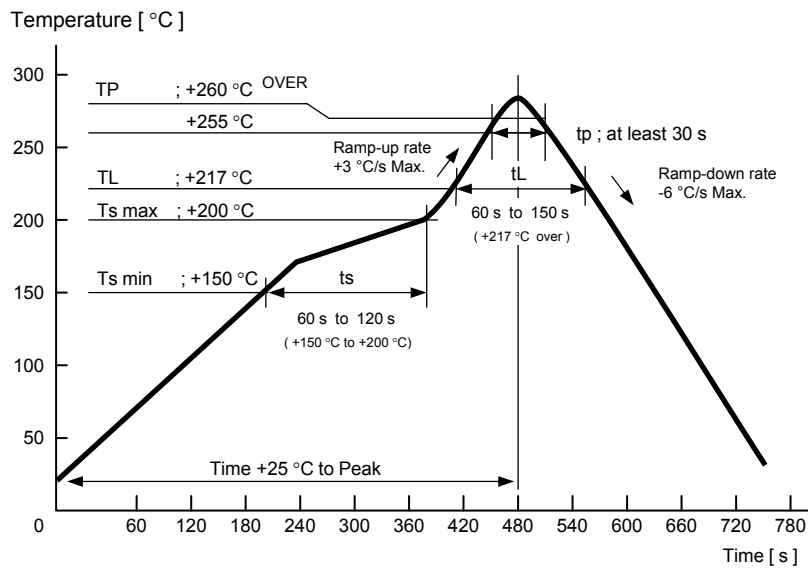
(The company evaluation condition. we evaluate it by the following examination item and examination condition.)

No.	Item	Value *1	Test method
		Freq. Tolerance [1×10 ⁻⁶] *2 Electrical characteristics	
1	High temp. storage *3	± 2.0	+85 °C × 1000 h
2	Low temp. storage *3	± 2.0	-40 °C × 1000 h
3	High temp. with humidity	± 2.0	+85 °C × 85%RH × 1000 h
4	Temp. cycle *3	± 2.0	-40 °C to +85 °C (30 min × 100 cycle/each)
5	Resistance to Soldering heat (Reflow characteristics)	± 1.0	Reflow furnace with the condition 3 times
6	Drop	± 2.0	150g dummy jig (SEIKO EPSON Standard) drop from 1500 mm height on the concrete 6 directions 3 times.
7	Vibration	± 2.0	10 Hz to 55 Hz amplitude 0.75 mm 55 Hz to 500 Hz acceleration 98 m/s ² 10 Hz → 500 Hz → 10 Hz 15 min / cycle 6 h (2 h × 3 directions)
8	Solderability	Terminals must be 95 % covered with fresh solder	Dip termination into solder bath at +235 °C for 5 s (Using Rosin Flux)

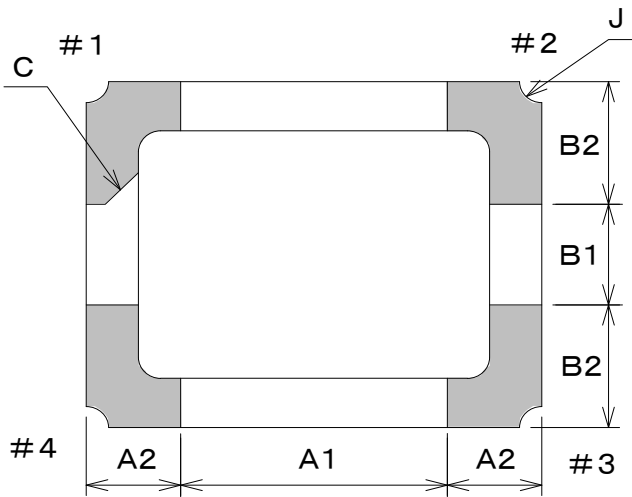
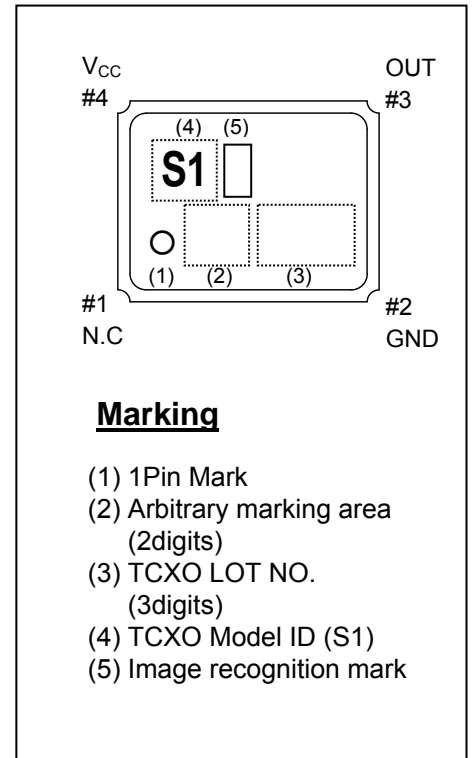
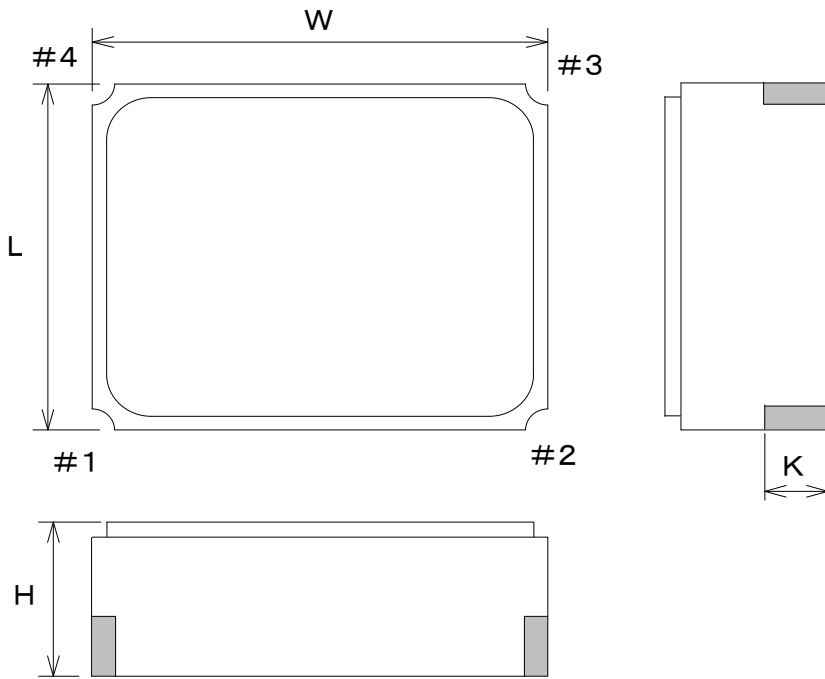
Notes

- 1.*1 each test is independent.
- 2.*2 measuring 2 h to 24 h later leaving in room temperature after each test.
- 3.*3 Pre conditionings
 1. reflow 2 times
 2. Initial value shall be after 24 h at room temperature.

Reflow condition (follow to IPC / JEDEC J-STD-020D.1)



[8] Dimensions and marking layout



Connection

Pin No.	Terminal
# 1	N.C.
# 2	GND
# 3	OUT
# 4	V _{CC}

Material

Base : Ceramics
Terminal : Au plated nickel

DIM.	MIN.	TYP.	MAX.
W	1.85	2.00	2.15
L	1.45	1.60	1.75
H	0.66	0.73	0.80
J	---	R0.10	---
K	---	0.27	---

Co-planarity : 0.05mm

(unit : mm)

DIM.	TYP.
A1	1.20
A2	0.4
B1	0.4
B2	0.6
C	C0.15

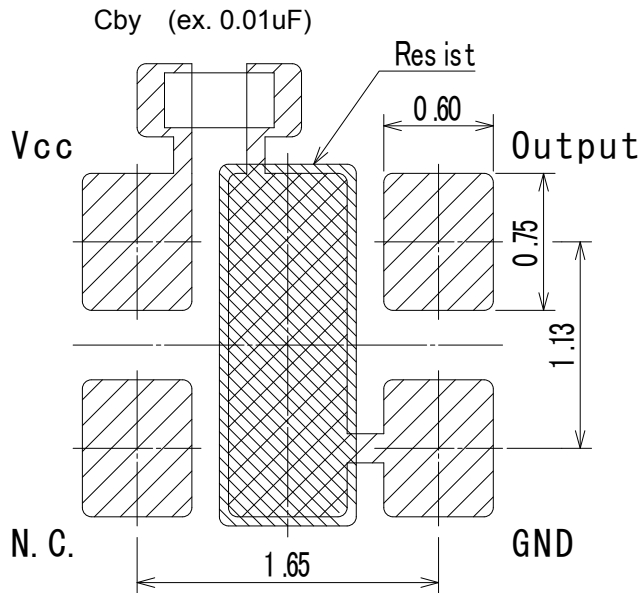
[9] Recommendable patterning

For actual design work, please consider optimum condition together with mounting density, reliability of soldering and mount ability etc.

Please connect Cby(bypass capacitor) quite near by "Vcc" terminal.
Do not design any patterns except GND on the shaded area.

Soldering position

Unit: mm



[10] Handling precautions

Prior to using this product, please carefully read the section entitled "Precautions" on our Web site (<http://www5.epsondevice.com/en/quartz/tech/precaution/>) for instructions on how to handle and use the product properly to ensure optimal performance of the product in your equipment. Before using the product under any conditions other than those specified therein, please consult with us to verify and confirm that the performance of the product will not be negatively affected by use under such conditions.

In addition to the foregoing precautions, in order to avoid the deteriorating performance of the product, we strongly recommend that you DO NOT use the product under ANY of the following conditions:

- (1) Mounting the product on a board using water-soluble solder flux and using the product without removing the residue of the flux completely from the board. The residue of such flux that is soluble in water or water-soluble cleaning agent, especially the residues which contains active halogens, will negatively affect the performance and reliability of the product.
- (2) Using the product in any manner that will result in any shock or impact to the product.
- (3) Using the product in places where the product is exposed to water, chemicals, organic solvent, sunlight, dust, corrosive gasses, or other materials.
- (4) Using the product in places where the product is exposed to static electricity or electromagnetic waves.
- (5) Applying ultrasonic cleaning without advance verification and confirmation that the product will not be affected by such a cleaning process, because it may damage the crystal, IC and/or metal line of the product.
- (6) Touching the IC surface with tweezers or other hard materials directly.
- (7) Using the product under any other conditions that may negatively affect the performance and/or reliability of the product.
- (8) Using the product with power line ripple exceeding 200 mV(p-p) level.

Should any customer use the product in any manner contrary to the precautions and/or advice herein, such use shall be done at the customer's own risk.

TAPING SPECIFICATION

テープ梱包基準書

1. APPLICATION 適用範囲

This document is applicable to 2.0 x 1.6 SMD package.

本基準書は、2.0 x 1.6 セラミックパッケージのテーピング梱包について規定する。

2. CONTENTS 目次

Item No.	Item	Page
[1]	Taping specification テーピング仕様	1 to 2
[2]	Inner Sleeve スリーブへの収納	3
[3]	Shipping carton 外装箱への収納	
[4]	Marking 表示	4
[5]	Quantity 収納数量	
[6]	Storage environment 保管環境	
[7]	Handling リール取扱い	

[1] Taping specification テーピング仕様

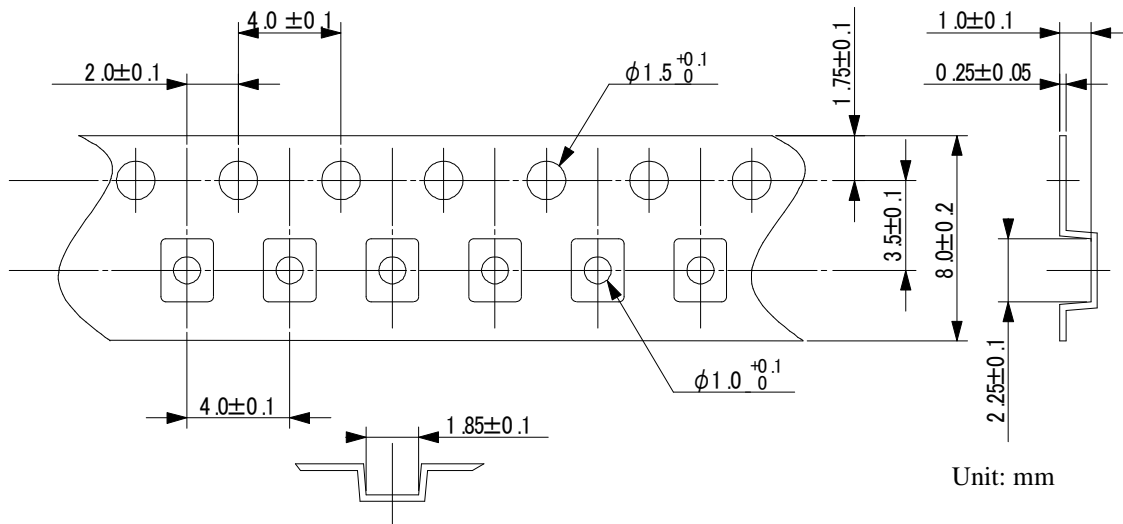
Subject to EIA-481 , IEC 60286.

「EIA-481」「IEC 60286」に準拠する。

(1) Tape dimensions TE0804L

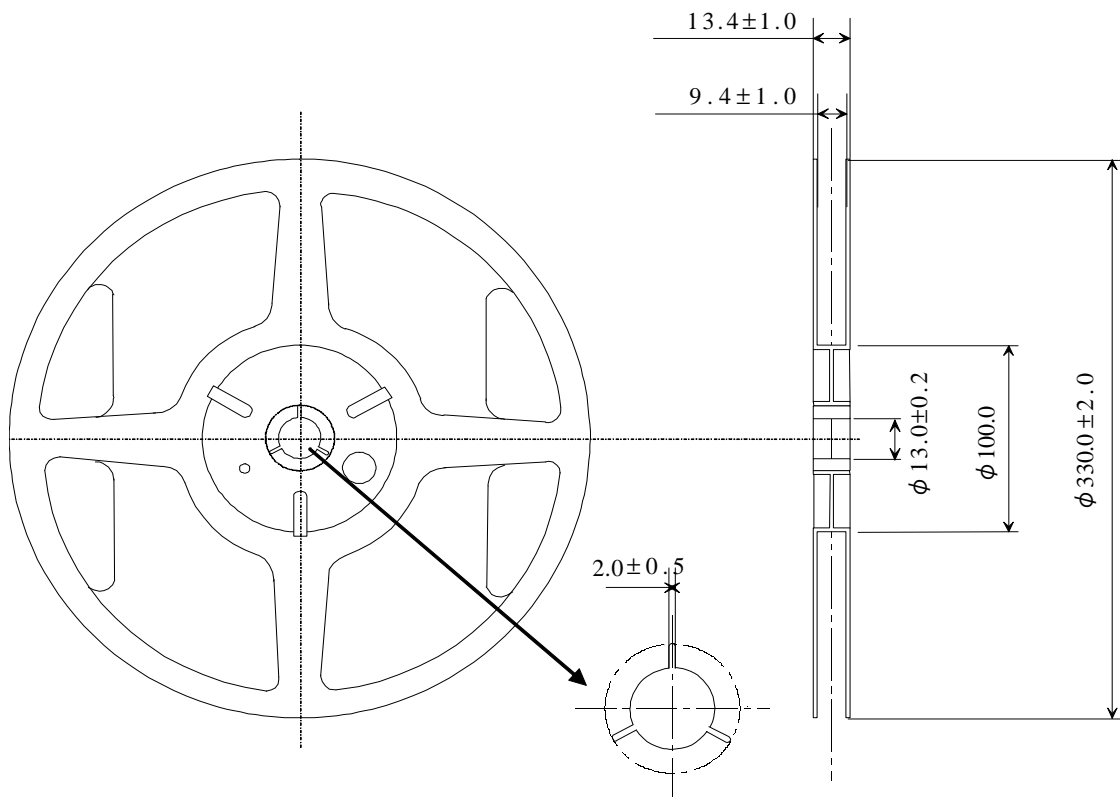
Material of the Carrier Tape キャリアテープ材質: PS (Black / Conductive 黒/導電性)

Material of the Top Tape トップテープ材質 : PET+PE



(2) Reel dimensions

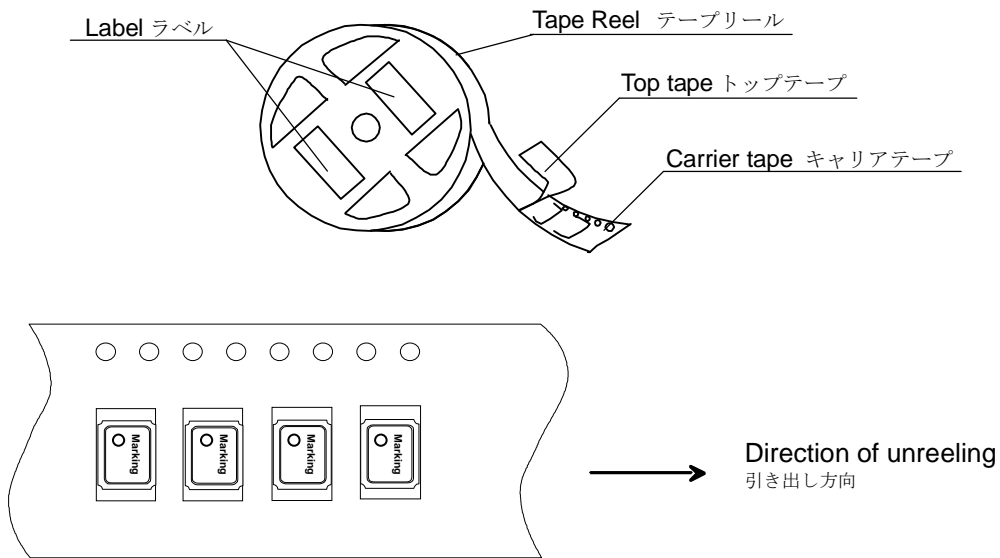
Material of the Reel リール材質: PS (Black / Conductive 黒/導電性)



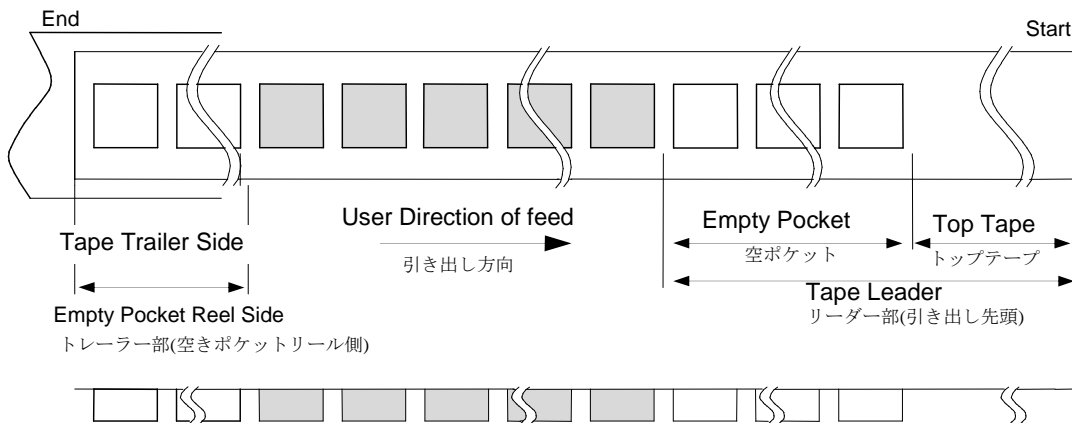
Form and Size of reel window shows are one of the example

リールの窓の形状は代表例を掲載。

(3) Packing 収納形態
 (a) Tape & Reel デバイス収納方法



(b) Start & End Point 引き出し先頭側及びリール側の処理



Item 項目		Empty Space 空きスペース	Note 備考
Tape Leader (引き出し先頭側)	Top Tape	Min. 200 mm	Feeding in the Top tape, the tip is fixed with tape. トップテープ単独で繰り出し、先端はテープにより固定。
	Carrier Tape	Min. 150 mm	Winding method is a diagram of the above リールへの巻き取り方法は、上図の通り。
Tape Trailer (リール側)	Top Tape	Min. 0 mm	Tip is fixed to the reel. 先端はリールに固定。
	Carrier Tape	Min. 150 mm	

(4) Peel force of the cover tape トップテープの剥離強度

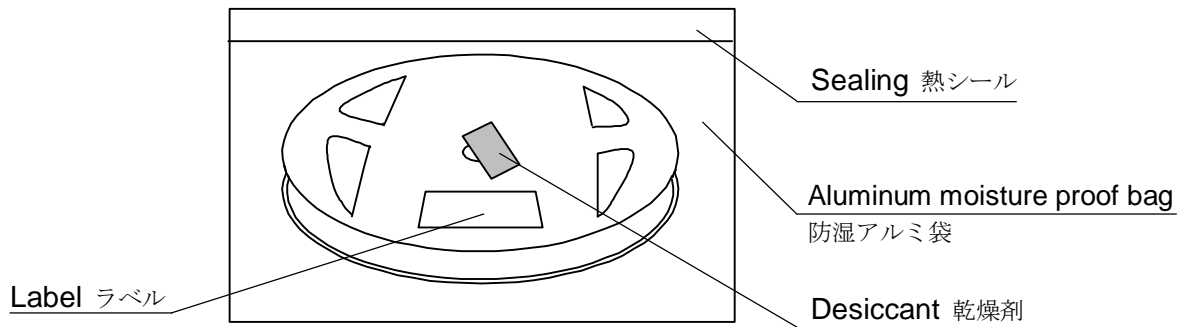
(a) Angle: cover tape during peel off and the direction of unreeling shall be 165° to 180°.
 剥離角度: テープの接着面に対し 165~180 度とする。

(b) Peel speed: 300 mm/min.
 剥離速度: 300 mm/min とする。

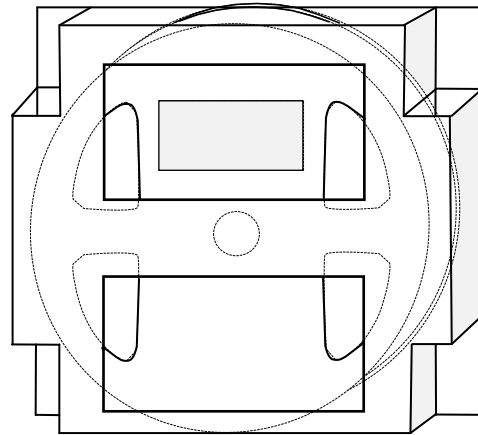
(c) Peel strength: 0.1 ~ 1.0 N.
 剥離強度: 0.1~1.0 N

[2] Inner sleeve

a) Packing to antistatic bag 袋への収納

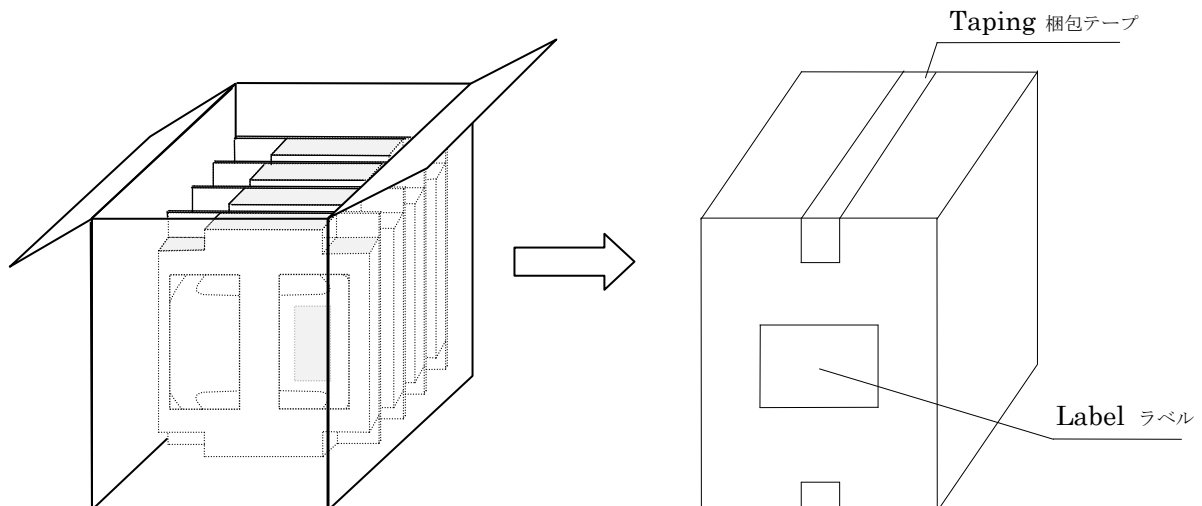


b) Packing to inner sleeve スリーブへの収納



[3] Shipping Carton 外装箱への収納

- Put inner sleeve into an outer box.
外装箱の中へ、スリーブを収納する。
- If there is space in the outer box, material is put in a shock absorbing together.
空間ができた時は、クッション材を入れる。



[4] Marking 表示

(1) Reel marking リールへの表示

- Reel marking shall consist of

下記内容をリール表面に表示できるラベルを貼る。:

- 1) Parts name 製品名称
- 2) Quantity 製品数量
- 3) Manufacturing Date or symbol 製品の製造年月又はこれを示す記号
- 4) Manufacturer's Date or symbol 製品の製造業者又はその略号
- 5) Others (if necessary) その他必要事項

(2) Shipping carton marking 外装箱への表示

- Shipping carton marking shall consist of :

下記内容を外装箱表面に表示できるラベルを貼る。:

- 1) Parts name 製品名称
- 2) Quantity 製品数量

[5] Quantity 収納数量

- Maximum 12 000 pcs./reel 最大 12,000 個/リール
- Minimum 500 pcs./reel 最小 500 個/リール

[6] Storage environment 保管環境

(1) Before open the packing, we recommend to keep less than +30 °C and 85 %RH of Humidity, and to use it less than 6 months after delivery.

開梱前の製品は、温度 +30 °C、湿度 85 %RH 以下での保管をして下さい。

貴社納入後、袋未開封で6ヶ月以内の実装を推奨します。

(2) We recommend to open Package in immediately before use. After open Package, We recommend to keeps less than 6 month. No need dry air before soldering work if it is less than temperature +30 °C, 85 humidity %RH. When keeping six months are exceeded after the opening, it is recommended to be used after soldering is confirmed.

使用直前まで開梱せず、袋開封後は6ヶ月以内の実装を推奨します。

温度 +30 °C、湿度 85 %RH 以下では、はんだ付け作業前に乾燥不要です。

開封後保管6ヶ月を超えた場合は半田付け性を確認の上使用されることを推奨します。

(3) Not to storage with some erosive chemicals.

化学薬品類との同居を避ける。

(4) Nothing is allowed to put on the reel or carton to prevent mechanical damage.

内・外装箱がゆがまないようまた、外圧がかからないように保管して下さい。

[7] Handling リール取扱い

To handle with care to prevent the damage of tape, reel and products.

リールの取扱いについては、中のテープ・製品を変形させないようにして下さい。

- PROCESS QUALITY CONTROL -

No. TG50xxCx_Q_0001

CRYSTAL OSCILLATOR : TG2016 series

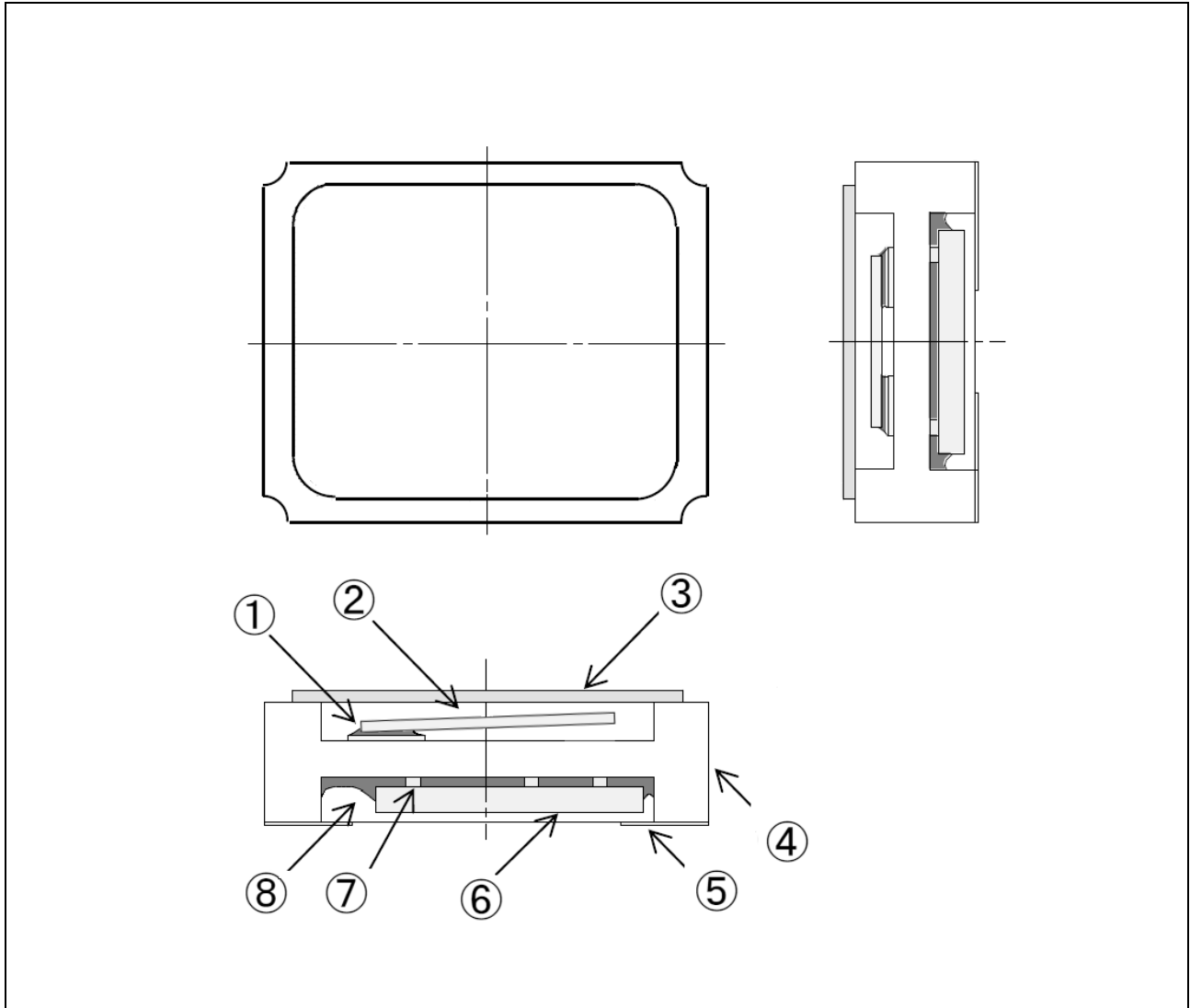
2015.03.26
TG2016_Q_0001

Manufacturing process chart		No.	Section In Charge	Standards	Inspection, Control Item	Instruments	Inspection Methods	Record
<p>The diagram shows a vertical flow of 22 steps. Step 1 is 'In-coming Inspection' (diamond). Step 2 is 'Bump Bonding' (circle). Step 3 is 'Tape mounting' (circle). Step 4 is 'Dicing' (circle). Step 5 is 'Wafer Cleaning' (circle). Step 6 is 'Appearance Inspection' (diamond). Step 7 is 'UV irradiation' (circle). Step 8 is 'Plasma etching' (circle). Step 9 is 'Flip chip bonding' (circle). Step 10 is 'Appearance inspection' (diamond). Step 11 is 'Under fill filling' (circle). Step 12 is 'Curing' (circle). Step 13 is 'Appearance inspection' (diamond). Step 14 is 'Reflow' (circle). Step 15 is '1st Temp. characteristic test' (circle). Step 16 is 'ROM writing' (circle). Step 17 is 'Temperature characteristic inspection' (diamond). Step 18 is 'Electrical characteristic inspection' (diamond). Step 19 is 'Marking' (circle). Step 20 is 'Taping' (circle). Step 21 is 'Out going inspection' (diamond). Step 22 is 'Packaging & Shipping' (circle). There are two boxes labeled 'Consistent equipment' on the left side, one between steps 15-17 and another between steps 18-20.</p>	1	Inspection Section	Purchase specification Delivery card	Appearance	Visual inspection	Every lot	Data sheet	
	2	Production Section	Specification (Work standard)	Heater temperature Bump dimension Shear strength	Thermometer Microscope Bond tester	Daily Sampling Sampling	Daily check sheet Data sheet Data sheet	
	3	Production Section	Specification (Work standard)	Cutting condition Appearance	Visual inspection	Daily	Daily check sheet	
	4	Production Section	Specification (Work standard)	Abrasion loss of Blade	Built-in gauge	Every batch	Tool change check sheet	
	5	Production Section	Specification (Work standard)	Water resistance	Built-in meter	Daily	Daily check sheet	
	6	Production Section	Specification (Work standard)	Dicing condition	Microscope	Sampling	Data sheet	
	7	Production Section	Specification (Work standard)	UV condition	UV intensity meter	Daily	Daily check sheet	
	8	Production Section	Specification (Work standard)	Flow rate of O2 and Ar	Built-in meter	Daily	Daily check sheet	
	9	Production Section	Specification (Work standard)	Number of US tool shots Number of ejector needle shot. Heater temperature Bump dimension Shear strength	Built-in counter Built-in counter Thermometer Microscope Bond tester	100% 100% Daily Sampling Sampling	Tool change check sheet Daily check sheet Data sheet Data sheet	
	10	Production Section	Specification (Work standard)	Flipchip bonding Condition	Microscope	Sampling	Data sheet	
	11	Production Section	Specification (Work standard)	Chip coat storage temp. Pot lifetime	Thermometer Built-in timer	Daily 100%	Daily check sheet Tool change check sheet	
	12	Production Section	Specification (Work standard)	Curing time Oven temperature	Timer Thermometer	Every batch Daily	Data sheet Daily check sheet	
	13	Production Section	Specification (Work standard)	Appearance (FC & Under fill condition)	Microscope	100% Inspection	Data sheet	
	14	Production Section	Specification (Work standard)	Reflow profile	Thermometer	Daily	Daily check sheet	
	15	Production Section	Specification (Work standard)	Stage temperature	Thermometer	Daily	Daily check sheet	
	16	Production Section	Specification (Work standard)	Stage temperature Temperature characteristic	Thermometer Measuring equipment	Daily 100% Inspection	Daily check sheet Data sheet	
	17	Production Section	Specification (Work standard)	Electrical characteristics Master confirmation	Measuring equipment	100% Inspection	Data sheet	
	18	Production Section	Specification (Work standard)	Appearance Marking	CCD camera	100% Inspection	Data sheet	
	19	Production Section	Specification (Work standard)	Peeling off strength Direction	Peel back tester Visual inspection	Daily Sampling Delivery lot	Daily check sheet Data sheet	
	20	Inspection Section	Specification (Work standard)	Electrical characteristics Appearance	Measuring equipment Visual inspection	Sampling	Data sheet	
	21	Production Control Section	Specification (Work standard)	Quantity	Visual inspection	Sampling Delivery lot	Data sheet Delivery record	
	22	Production Control Section	Specification (Work standard)	Quantity	Visual inspection	Sampling Delivery lot	Data sheet Delivery record	

Structure Diagram 構造図

Rev.02

Model 型式	TG2016 series	TG2016SBx
Document No. 管理No.	-	TG2016_D_0001



⑧	UF UF	
⑦	FC bump FC バンプ	
⑥	IC IC	
⑤	Terminal 端子	
④	Package パッケージ	
③	Lid リッド	
②	Crystal chip 水晶片	
①	Crystal Adhesive 水晶接着	
No.	Name of Part 部品名	

RELIABILITY TEST DATA
Product Name : TG2016SBN

The Company evaluation condition

We evaluate environmental and mechanical characteristics by the following test condition .

DTA-1508_E

No.	ITEM	TEST CONDITIONS	VALUE *1		TEST	FAIL
			$\Delta f / f$ *2 [1×10^{-6}]	Electrical characteristics	Qty [n]	Qty [n]
1	High temperature storage	+85 °C × 1 000 h	*3 ± 2.0	Satisfy output level after test	22	0
2	Low temperature storage	-40 °C × 1 000 h	*3 ± 2.0		22	0
3	High Temperature with Humidity	+85 °C × 85 %RH × 1 000 h	*3 ± 2.0		22	0
4	Temperature cycle	-40 °C ⇔ +85 °C 30 min at each temp. 1000 cycles	*3 ± 2.0		22	0
5	Resistance to soldering heat	Convection reflow soldering furnace (3 times)	± 1.0		22	0
6	Drop	150g dummy jig (SEIKO EPSON Standard) drop from 1500 mm height on the concrete 6 directions 3 times.	± 2.0		22	0
7	Vibration	10 Hz to 55 Hz amplitude 0.75 mm 55 Hz to 500 Hz acceleration 98 m/s ² 10 Hz → 500 Hz → 10 Hz 15 min / cycle 6 h (2 h × 3 directions)	± 2.0		22	0
8	Solderability	Dip termination into solder bath at +235 °C ± 5 °C for 5 s	Termination must be covered with fresh solder more than 95 % of dip area.		11	0

Notes

- *1 Each test done independently.
- *2 Measuring 2 h to 24 h later leaving in room temperature after each test.
- *3 Initial value shall be measured after 24 h storage at room temperature Pre-treatment
Pre-treatment : Bake (+125 °C × 24 h) →Moisture soak (+85 °C × 85 % × 168 h) →reflow (3 times)

Product Name : TG2016SBN

df / f

